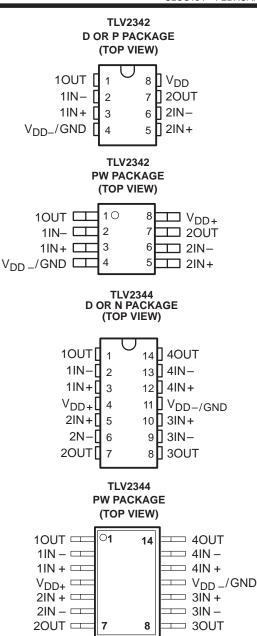
TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997

- Wide Range of Supply Voltages Over Specified Temperature Range: -40°C to 85°C ... 2 V to 8 V
- Fully Characterized at 3 V and 5 V
- Single-Supply Operation
- Common-Mode Input-Voltage Range Extends Below the Negative Rail and Up to V_{DD}-1 V at 25°C
- Output Voltage Range Includes Negative Rail
- High Input Impedance . . . $10^{12} \Omega$ Typical
- ESD-Protection Circuitry
- Designed-In Latch-Up Immunity

description

The TLV234x operational amplifiers are in a family of devices that has been specifically designed for use in low-voltage single-supply applications. Unlike other products in this family designed primarily to meet aggressive power consumption specifications, the TLV234x was developed to offer ac performance approaching that of a BiFET operational amplifier while operating from a single-supply rail. At 3 V, the TLV234x has a typical slew rate of 2.1 V/µs and 790-kHz unity-gain bandwidth.

Each amplifier is fully functional down to a minimum supply voltage of 2 V and is fully characterized, tested, and specified at both 3-V and 5-V power supplies over a temperature range of -40° C to 85° C. The common-mode input voltage range includes the negative rail and extends to within 1 V of the positive rail.



AVAILABLE OPTIONS

	M may		PACKAGED	DEVICES		
ТА	V _{IO} max AT 25°C	SMALL OUTLINE [†] (D)	PLASTIC DIP (N)	PLASTIC DIP (P)	TSSOP‡ (PW)	CHIP FORM§ (Y)
-40°C to 85°C	9 mV	TLV2342ID	—	TLV2342IP	TLV2342IPWLE	TLV2342Y
-40 0 10 03 0	10 mV	TLV2344ID	TLV2344IN	—	TLV2344IPWLE	TLV2344Y

[†] The D package is available taped and reeled. Add R suffix to the device type (e.g., TLV2342IDR).

[‡]The PW package is only available left-end taped and reeled (e.g., TLV2342IPWLE).

§ Chip forms are tested at 25°C only.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

LinCMOS is a trademark of Texas Instruments Incorporated.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 1997, Texas Instruments Incorporated

TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997

SLOS 194 - FEBRUART 1997

description (continued)

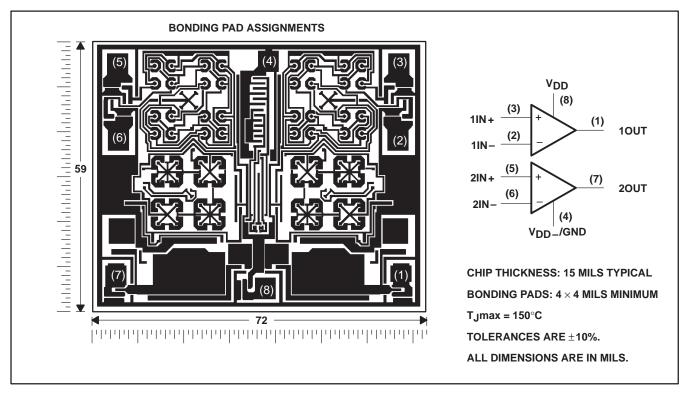
Low-voltage and low-power operation has been made possible by using the Texas Instruments silicon-gate LinCMOS technology. The LinCMOS process also features extremely high input impedance and ultra-low input bias currents. These parameters combined with good ac performance make the TLV234x effectual in applications such as high-frequency filters and wide-bandwidth sensors.

To facilitate the design of small portable equipment, the TLV234x is made available in a wide range of package options, including the small-outline and thin-shrink small-outline packages (TSSOP). The TSSOP package has significantly reduced dimensions compared to a standard surface-mount package. Its maximum height of only 1.1 mm makes it particularly attractive when space is critical.

The device inputs and outputs are designed to withstand –100-mA currents without sustaining latch-up. The TLV234x incorporates internal ESD-protection circuits that prevents functional failures at voltages up to 2000 V as tested under MIL-PRF-38535, Method 3015.2; however, care should be exercised in handling these devices as exposure to ESD may result in the degradation of the device parametric performance.

TLV2342Y chip information

This chip, when properly assembled, displays characteristics similar to the TLV2342. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

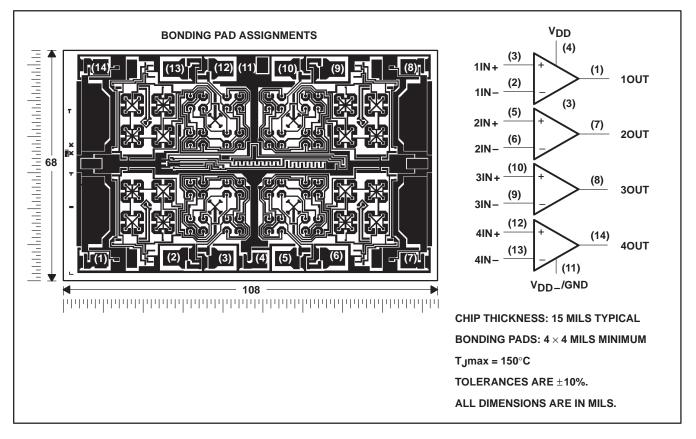




TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997

TLV2344Y chip information

This chip, when properly assembled, displays characteristics similar to the TLV2344. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

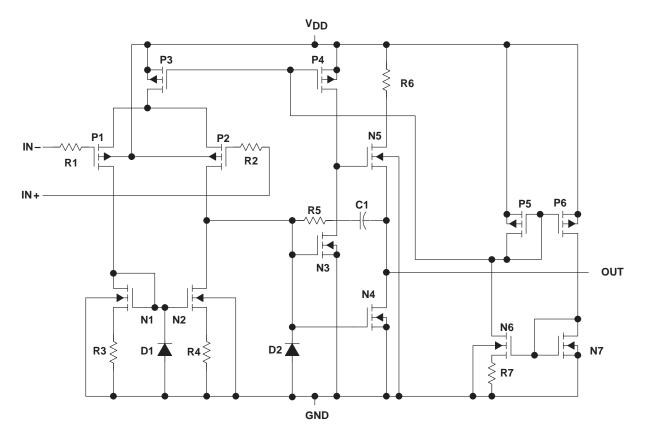




TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS™ LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 – FEBRUARY 1997

equivalent schematic (each amplifier)



ACTUAL DEVICE COMPONENT COUNT								
COMPONENT	TLV2342	TLV2344						
Transistors	54	108						
Resistors	14	28						
Diodes	4	8						
Capacitors	2	4						

[†] Includes both amplifiers and all ESD, bias, and trim circuitry.



absolute maximum ratings over operating free-air temperature (unless otherwise noted)[†]

Supply voltage, V_{DD} (see Note 1) Differential input voltage, V_{ID} (see Note 2) Input voltage range, V_I (any input) Input current, I_I Output current, I_O Duration of short-circuit current at (or below) $T_A = 25^{\circ}C$ (see Note 3) Continuous total dissipation Operating free-air temperature range, T_A Storage temperature range	
Storage temperature range Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to network ground.

2. Differential voltages are at the noninverting input with respect to the inverting input.

3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded (see application selection).

	DISSILAI	ION RATING TABLE	
PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 85°C POWER RATING
D-8	725 mW	5.8 mW/°C	377 mW
D–14	950 mW	7.6 mW/°C	494 mW
N	1575 mW	5.6 mW/°C	364 mW
Р	1000 mW	8.0 mW/°C	520 mW
PW–8	525 mW	4.2 mW/°C	273 mW
PW-14	700 mW	6.0 mW/°C	340 mW

DISSIPATION RATING TABLE

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{DD}		2	8	V
Common-mode input voltage, VIC	V _{DD} = 3 V	-0.2	1.8	V
Common-mode input voltage, v[C	V _{DD} = 5 V	-0.2	3.8	v
Operating free-air temperature, T _A		-40	85	°C



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS™ LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 – FEBRUARY 1997

TLV2342I electrical characteristics at specified free-air temperature

						TLV2	3421			
	PARAMETER	TEST CONDITIONS	т _A †	v	DD = 3 \	1	V	DD = 5 \	/	UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
VIO	Input offset voltage	$V_{O} = 1 V$, $V_{IC} = 1 V$, $R_{S} = 50 \Omega$,	25°C		0.6	9		1.1	9	mV
v10	input onset voltage	$R_L = 10 k\Omega$	Full range			11			11	1110
αΛΙΟ	Average temperature coefficient of input offset voltage		25°C to 85°C		2.7			2.7		μV/°C
lio	Input offset current	V _O = 1 V, V _{IC} = 1 V	25°C		0.1			0.1		pА
10	(see Note 4)	VO = 1 V, VIC = 1 V	85°C		22	1000		24	1000	рл.
Iв	Input bias current (see Note 4)	$V_{O} = 1 V$, $V_{IC} = 1 V$	25°C		0.6			0.6		pА
	······································		85°C		175	2000		200	2000	P
\ <i>\</i>	Common-mode input voltage		25°C	-0.2 to 2	-0.3 to 2.3		-0.2 to 4	-0.3 to 4.2		V
VICR	range (see Note 5)		Full range	-0.2 to 1.8			-0.2 to 3.8			V
		V _{IC} = 1 V,	25°C	1.75	1.9		3.2	3.7		
Vон	High-level output voltage	V _{ID} = 100 mV, I _{OH} = -1 mA	Full range	1.7			3			V
		$V_{IC} = 1 V,$	25°C		120	150		90	150	
VOL	Low-level output voltage	$V_{ID} = -100 \text{ mV},$ $I_{OL} = 1 \text{ mA}$	Full range			190			190	mV
A. (5	Large-signal differential	$V_{IC} = 1 V,$ $R_L = 10 k\Omega,$	25°C	3	11		5	23		V/mV
AVD	voltage amplification	See Note 6	Full range	2			3.5			V/IIIV
CMRP	Common-mode rejection ratio	$V_{O} = 1 V,$ $V_{IC} = V_{ICR}min,$	25°C	65	78		65	80		dB
		$R_{S} = 50 \Omega$	Full range	60			60			uВ
ksvr	Supply-voltage rejection ratio	$V_{IC} = 1 V, V_{O} = 1 V,$	25°C	70	95		70	95		dB
0.01	$(\Delta V_{DD}/\Delta V_{IO})$	R _S = 50 Ω	Full range	65			65			
DD	Supply current	$V_{O} = 1 V$, $V_{IC} = 1 V$,	25°C		0.65	3		1.4	3.2	mA
	No load	Full range			4			4.4		

[†]Full range is –40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA are determined mathematically.

5. This range also applies to each input individually.

6. At V_DD = 5 V, V_O = 0.25 V to 2 V; at V_DD = 3 V, V_O = 0.5 V to 1.5 V.



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED **OPERATIONAL AMPLIFIERS**

SLOS194 - FEBRUARY 1997

TLV2342I operating characteristics at specified free-air temperature, V_{DD} = 3 V

	DADAMETED	TFOT O			TLV2342I			
	PARAMETER	TEST C	ONDITIONS	I A I	TA MIN TYI 25°C 2. 85°C 1. 25°C 2. 25°C 2. 25°C 1. 25°C 1. 25°C 1. 25°C 1.1 25°C 1.1 85°C 1.1 85°C 1.4 25°C 79 85°C 69 -40°C 53	TYP	MAX	UNIT
SR		$V_{IC} = 1 V$, $V_{I}(PP) = 1 V$		25°C		2.1		Mar
SK	Slew rate at unity gain	$R_L = 10 \text{ k}\Omega$, See Figure 34	C _L = 20 pF,	85°C		1.7		V/μs
V _n	Equivalent input noise voltage	f = 1 kHz, See Figure 35	R _S = 20 Ω,	25°C		25		nV/√Hz
Deri		$V_{O} = V_{OH},$	C ₁ = 20 pF,	25°C		170		kHz
BOM	Maximum output-swing bandwidth	$R_L = 10 k\Omega$,	See Figure 34	85°C		145		кни
D	linity goin hondwidth	V _I = 10 mV,	C ₁ = 20 pF,	25°C		790		kHz
B ₁	Unity-gain bandwidth	R _L = 10 kΩ,	See Figure 36	85°C		690		КПИ
		V _I = 10 mV,	f = B ₁ ,	-40°C		53°		
φm	Phase margin	$C_{L} = 20 \text{ pF},$	$R_L = 10 k\Omega$,	25°C		49°		
		See Figure 36		85°C		47°		

TLV2342I operating characteristics at specified free-air temperature, V_{DD} = 5 V

	PARAMETER	TEST CO	ONDITIONS	т.	Т	LV2342I		UNIT
	PARAMETER	TEST CO	JNDITIONS	TA	MIN TYP MA 3.6 3.6 2.8 2.9 2.3 2.3 2.5 320	MAX	UNIT	
		V _{IC} = 1 V,		25°C		3.6		
SR	Slew rate at unity gain	$R_L = 10 k\Omega$,	$V_{I(PP)} = 1 V$	85°C		2.8		Mura
	Siew rate at unity gain	$C_{L} = 20 \text{ pF},$	PF,	25°C		2.9		V/μs
		See Figure 34		85°C		2.3		
Vn	Equivalent input noise voltage	f = 1 kHz, See Figure 35	R _S = 20 Ω,	25°C		25		nV/√ Hz
Davis		V _O = V _{OH} ,	C ₁ = 20 pF,	25°C		320		
BOM	Maximum output-swing bandwidth	$R_L = 10 k\Omega$,	See Figure 34	85°C		250		kHz
		V _I = 10 mV,	C _L = 20 pF,	25°C		1.7		kHz
B ₁	Unity-gain bandwidth	$R_{L} = 10 \text{ k}\Omega,$	See Figure 36	85°C		1.2		КПИ
		V _I = 10 mV,	f = B ₁ ,	-40°C		49°		
۹m	Phase margin	$C_{L} = 20 \text{ pF},$	$R_L = 10 \text{ k}\Omega$,	25°C		46°		
		See Figure 36		85°C		43°		



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS™ LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 – FEBRUARY 1997

TLV2344I electrical characteristics at specified free-air temperature

						TLV2	3441				
	PARAMETER	TEST CONDITIONS	T _A †	v	DD = 3 \	/	V	DD = 5 \	/	UNIT	
		CONDITIONO		MIN	TYP	MAX	MIN	TYP	MAX		
VIO	Input offset voltage	$V_{O} = 1 V,$ $V_{IC} = 1 V,$	25°C		1.1	10		1.1	10	mV	
10	nipat onoot voitago	R _S = 50 Ω, R _L = 10 kΩ	Full range			12			12		
αΛΙΟ	Average temperature coefficient of input offset voltage		25°C to 85°C		2.7			2.7		μV/°C	
10	Input offset current (see Note 4)	V _O = 1 V,	25°C		0.1			0.1		pА	
UO	input onset current (see Note 4)	$V_{IC} = 1 V$	85°C		22	1000		24	1000	рА	
IB	Input bias current (see Note 4)	V _O = 1 V,	25°C		0.6			0.6		pА	
.ID		V _{IC} = 1 V	85°C		175	2000		200	2000		
	Common-mode input voltage range		25°C	-0.2 to 2	-0.3 to 2.3		-0.2 to 4	-0.3 to 4.2		V	
VICR	(see Note 5)		Full range	-0.2 to 1.8			-0.2 to 3.8			V	
		V _{IC} = 1 V,	25°C	1.75	1.9		3.2	3.7			
VOH	High-level output voltage	V _{ID} = 100 mV, I _{OH} = -1 mA	Full range	1.7			3			V	
Va	Low-level output voltage	V _{IC} = 1 V, V _{ID} = -100 mV,	25°C		120	150		90	150	mV	
VOL	Low-level output voltage	$I_{OL} = 1 \text{ mA}$	Full range			190			190	IIIV	
•	Large-signal differential	$V_{IC} = 1 V,$ $R_I = 10 k\Omega,$	25°C	3	11		5	23			
A _{VD}	voltage amplification	$R_L = 10 \text{ k}_{2},$ See Note 6	Full range	2			3.5			V/mV	
	Common mode minsting actin	$V_0 = 1 V$,	25°C	65	78		65	80		40	
CMRR	Common-mode rejection ratio	$V_{IC} = V_{ICR}$ min, R _S = 50 Ω	Full range	60			60			dB	
	Supply-voltage rejection ratio	$V_{IC} = 1 V$,	25°C	70	95		70	95			
ksvr	$(\Delta V_{DD}/\Delta V_{IO})$	$V_{O} = 1 V,$ $R_{S} = 50 \Omega$	Full range	65			65			dB	
1	Supply ourront	$V_0 = 1 V,$	25°C		1.3	6		2.7	6.4		
IDD	Supply current		pply current V _{IC} = 1 V, No load Full rang	Full range			8			8.8	mA

[†] Full range is -40° C to 85° C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA are determined mathematically.

5. This range also applies to each input individually.

6. At V_{DD} = 5 V, V_{O} = 0.25 V to 2 V; at V_{DD} = 3 V, V_{O} = 0.5 V to 1.5 V.



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS™ LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997

		TEOTO			TLV2344I			
	PARAMETER	TEST C	ONDITIONS	TA	MIN	TYP	MAX	UNIT
SR		$V_{IC} = 1 V,$ $R_{I} = 10 k\Omega,$	VI(PP) = 1 V, C _L = 20 pF,	25°C		2.1)//wa
SK	Slew rate at unity gain	See Figure 34		85°C		1.7		V/μs
v _n	Equivalent input noise voltage	f = 1 kHz, See Figure 35	R _S = 20 Ω,	25°C		25		nV/√Hz
Davi	Movimum output outing hondwidth	V _O = V _{OH} ,	C ₁ = 20 pF,	25°C		170		
ВОМ	Maximum output-swing bandwidth	$R_L = 10 k\Omega$,	See Figure 34	85°C		145		kHz
D	Lipite goin honduidth	$V_{I} = 10 \text{ mV},$	C ₁ = 20 pF,	25°C		790		kHz
B ₁	Unity-gain bandwidth	R _L = 10 kΩ,	See Figure 36	85°C		690		КПИ
		$V_{I} = 10 \text{ mV},$	f = B ₁ ,	-40°C		53°		
φm	Phase margin	C _L = 20 pF,	$R_L = 10 k\Omega$,	25°C	5°C 49	49°		
		See Figure 36		85°C		47°]

TLV2344I operating characteristics at specified free-air temperature, V_{DD} = 5 V

	PARAMETER	TEST CO	ONDITIONS	т.	Т	LV2344I		UNIT
	FARAMETER	TEST CO	JNDITIONS	'A	TA MIN TYP MAX 25°C 3.6	UNIT		
		V _{IC} = 1 V,		25°C		3.6		
SR	Slew rate at unity gain	$R_L = 10 k\Omega$,	VI(PP) = 1 V	85°C		2.8		V/μs
	Siew rate at unity gain	C _L = 20 pF,		25°C		2.9		v/µs
		See Figure 34	V _{I(PP)} = 2.5 V	85°C		2.3		
Vn	Equivalent input noise voltage	f = 1 kHz, See Figure 35	R _S = 20 Ω,	25°C		25		nV/√Hz
Davis		V _O = V _{OH} ,	CL = 20 pF,	25°C		320		
BOM	Maximum output-swing bandwidth	$R_L = 10 \text{ k}\Omega,$	See Figure 34	85°C		250		kHz
		V _I = 10 mV,	C _I = 20 pF,	25°C		1.7		MHz
B ₁	Unity-gain bandwidth	R _L = 10 kΩ,	See Figure 36	85°C		1.2		MIL
		$V_{I} = 10 \text{ mV},$	f = B ₁ ,	-40°C		49°		
φm	Phase margin	C _L = 20 pF,	$R_L = 10 k\Omega$,	25°C		46°		
		See Figure 36		85°C		43°		



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS™ LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 - FEBRUARY 1997

TLV2342Y electrical characteristics, $T_A = 25^{\circ}C$

					TLV2	342Y					
	PARAMETER	TEST C	TEST CONDITIONS			V _{DD} = 3 V			V _{DD} = 5 V		
				MIN	TYP	MAX	MIN	TYP	MAX		
VIO	Input offset voltage	$V_{O} = 1 V,$ R _S = 50 Ω ,	$V_{IC} = 1 V,$ $R_L = 10 k\Omega$		0.6			1.1		mV	
IIO	Input offset current (see Note 4)	V _O = 1 V,	$V_{IC} = 1 V$		0.1			0.1		pА	
I _{IB}	Input bias current (see Note 4)	V _O = 1 V,	$V_{IC} = 1 V$		0.6			0.6		pА	
VICR	Common-mode input voltage range (see Note 5)				-0.3 to 2.3			-0.3 to 4.2		V	
VOH	High-level output voltage	$V_{IC} = 1 V,$ $I_{OH} = -1 mA$	V _{ID} = 100 mV,		1.9			3.7		V	
V _{OL}	Low-level output voltage	$V_{IC} = 1 V$ $I_{OL} = 1 mA$	V _{ID} = 100 mV,		120			90		mV	
A _{VD}	Large-signal differential voltage amplification	V _{IC} = 1 V, See Note 6	R _L = 10 kΩ,		11			23		V/mV	
CMRR	Common-mode rejection ratio	$V_{O} = 1 V,$ $R_{S} = 50 \Omega$	$V_{IC} = V_{ICR}min$,		78			80		dB	
k SVR	Supply-voltage rejection ratio $(\Delta V_{DD}/\Delta V_{ID})$	$V_{O} = 1 V$ R _S = 50 Ω	V _{IC} = 1 V,		95			95		dB	
IDD	Supply current	V _O = 1 V, No load	V _{IC} = 1 V,		0.65			1.4		mA	

NOTES: 4. The typical values of input bias current and input offset current below 5 pA are determined mathematically.

5. This range also applies to each input individually.

6. At $V_{DD} = 5 \text{ V}$, $V_{O} = 0.25 \text{ V}$ to 2 V; at $V_{DD} = 3 \text{ V}$, $V_{O} = 0.5 \text{ V}$ to 1.5 V.



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED **OPERATIONAL AMPLIFIERS** SLOS194 - FEBRUARY 1997

			TLV2344Y							
	PARAMETER	TEST C	V _{DD} = 3 V			V _{DD} = 5 V			UNIT	
				MIN	TYP	MAX	MIN	TYP	MAX	
VIO	Input offset voltage	$V_{O} = 1 V,$ $R_{L} = 10 k\Omega$	$V_{IC} = 1 V,$ $R_L = 10 k\Omega$		1.1			1.1		mV
I _{IO}	Input offset current (see Note 4)	V _O = 1 V,	$V_{IC} = 1 V$		0.1			0.1		pА
I _{IB}	Input bias current (see Note 4)	V _O = 1 V,	$V_{IC} = 1 V$		0.6			0.6		pА
VICR	Common-mode input voltage range (see Note 5)				-0.3 to 2.3			-0.3 to 4.2		V
VOH	High-level output voltage	$V_{IC} = 1 V,$ $I_{OH} = -1 mA$	V _{ID} = 100 mV,		1.9			3.7		V
V _{OL}	Low-level output voltage	$V_{IC} = 1 V,$ $I_{OL} = 1 mA$	$V_{ID} = -100 \text{ mV},$		120			90		mV
AVD	Large-signal differential voltage amplification	V _{IC} = 1 V, See Note 6	R _L = 10 kΩ,		11			23		V/mV
CMRR	Common-mode rejection ratio	$V_{O} = 1 V,$ R _S = 50 Ω	$V_{IC} = V_{ICR}min$,		78			80		dB
k _{SVR}	Supply-voltage rejection ratio $(\Delta V_{DD}/\Delta V_{ID})$	$V_{O} = 1 V,$ R _S = 50 Ω	V _{IC} = 1 V,		95			95		dB
IDD	Supply current	V _O = 1 V, No load	V _{IC} = 1 V,		1.3			2.7		μA

TLV2344Y electrical characteristics, $T_A = 25^{\circ}C$

NOTES: 4. The typical values of input bias current and input offset current below 5 pA are determined mathematically.

5. This range also applies to each input individually. 6. At $V_{DD} = 5 V$, $V_O = 0.25 V$ to 2 V; at $V_{DD} = 3 V$, $V_O = 0.5 V$ to 1.5 V.



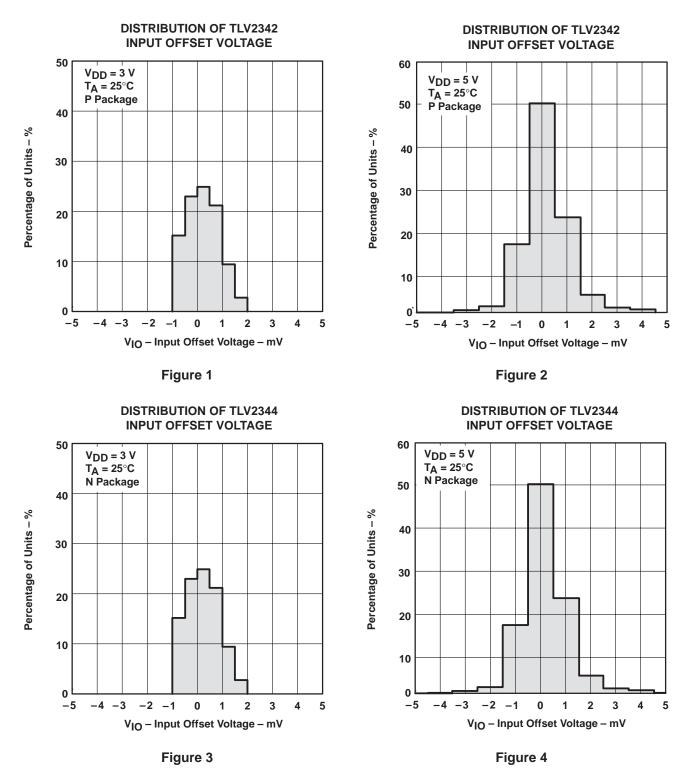
TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997

TYPICAL CHARACTERISTICS

Table of Graphs

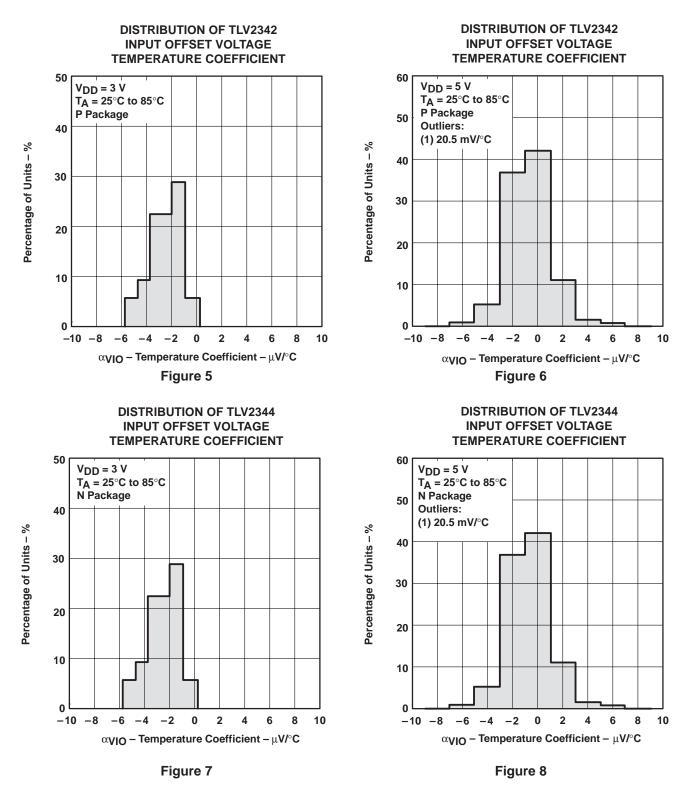
			FIGURE
VIO	Input offset voltage	Distribution	1 – 4
ανιο	Input offset voltage temperature coefficient	Distribution	5 – 8
I _{IB}	Input bias current	vs Free-air temperature	9
lio	Input offset current	vs Free-air temperature	9
VIC	Common-mode input voltage	vs Supply voltage	10
VOH	High-level output voltage	vs High-level output current vs Supply voltage vs Free-air temperature	11 12 13
Vol	Low-level output voltage	vs Common-mode input voltage vs Free-air temperature vs Differential input voltage vs Low-level output current	14 15, 16 17 18
AVD	Large-signal differential voltage amplification	vs Supply voltage vs Free-air temperature vs Frequency	19 20, 21 22, 23
IDD	Supply current	vs Supply voltage vs Free-air temperature	24 25
SR	Slew rate	vs Supply voltage vs Free-air temperature	26 27
V _{O(PP)}	Maximum peak-to-peak output voltage	vs Frequency	28
B ₁	Unity-gain bandwidth	vs Supply voltage vs Free-air temperature	29 30
[¢] m	Phase margin	vs Supply voltage vs Free-air temperature vs Load capacitance	31 32 33
	Phase shift	vs Frequency	22, 23
Vn	Equivalent input noise voltage	vs Frequency	34





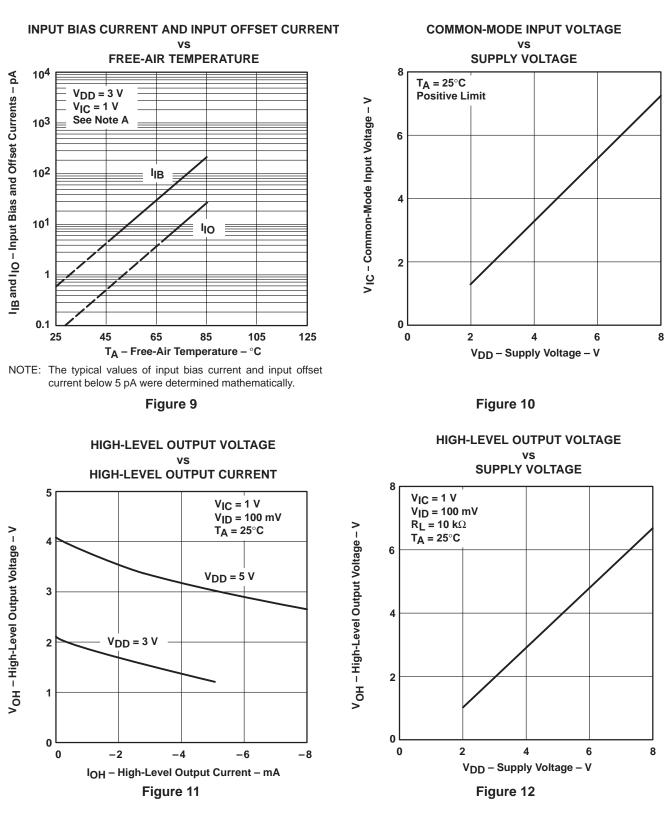


TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997



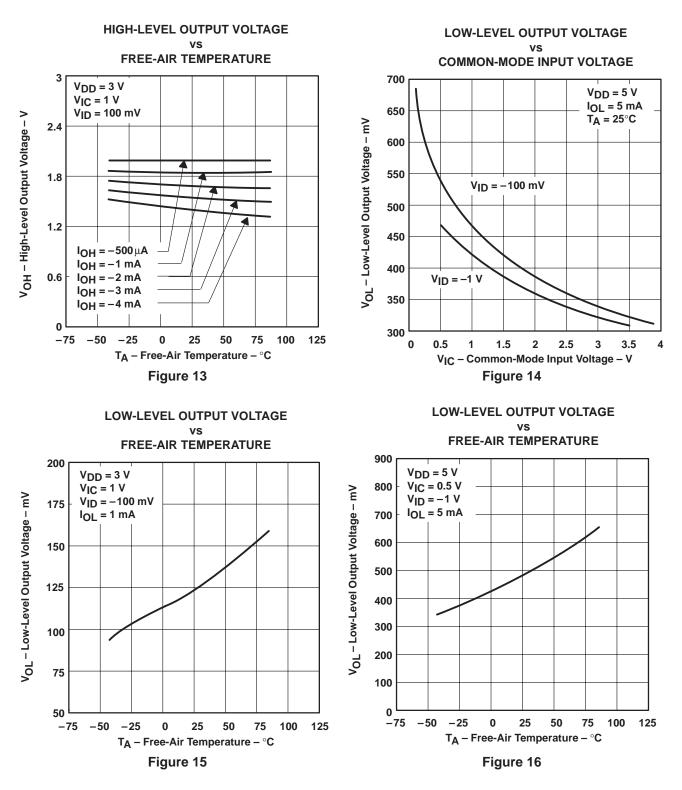


TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997

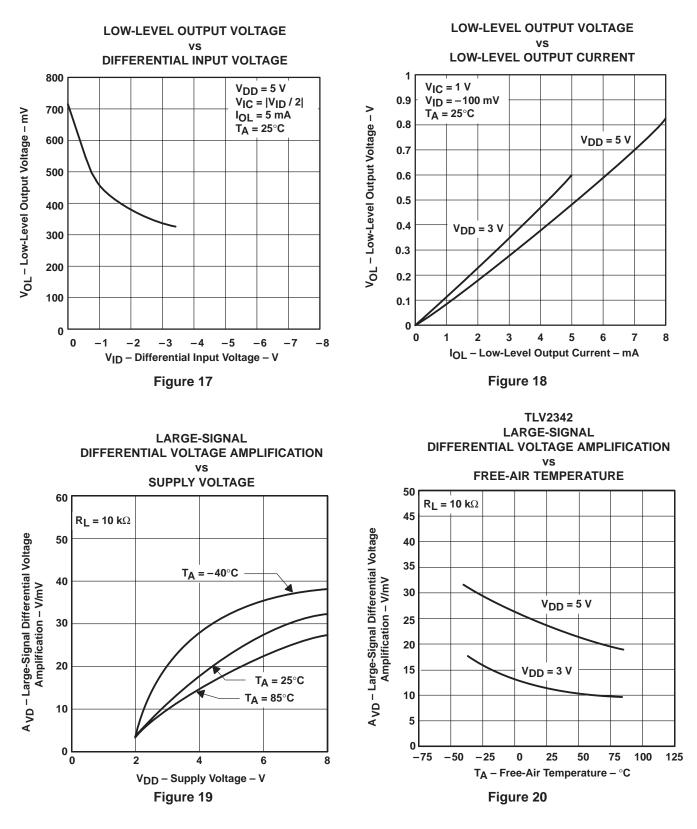




TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997









TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED **OPERATIONAL AMPLIFIERS**

SLOS194 - FEBRUARY 1997



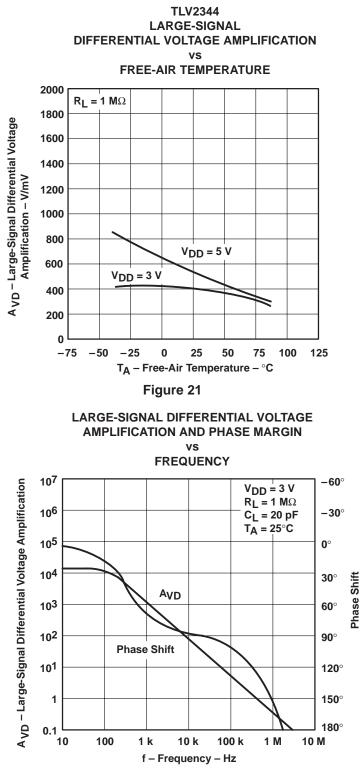


Figure 22



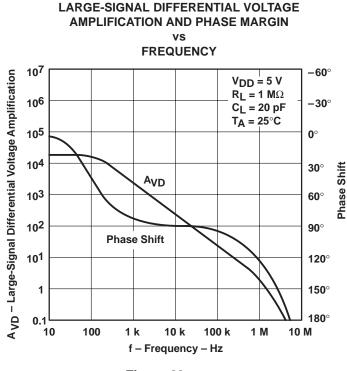
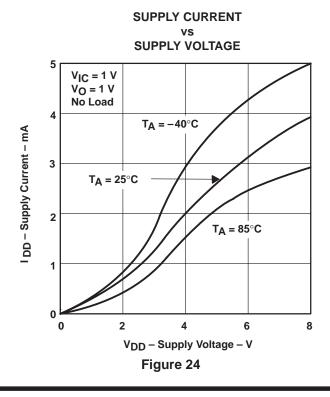
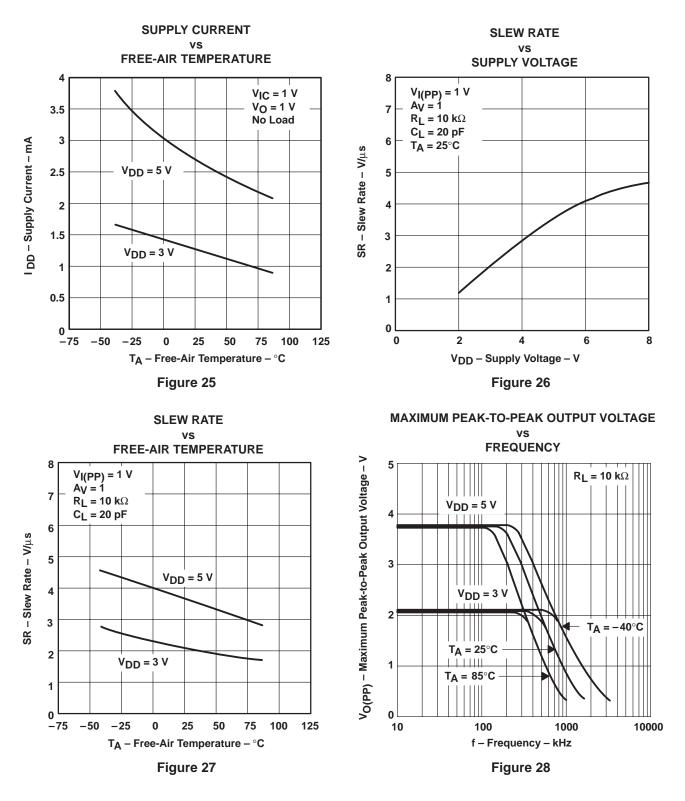


Figure 23



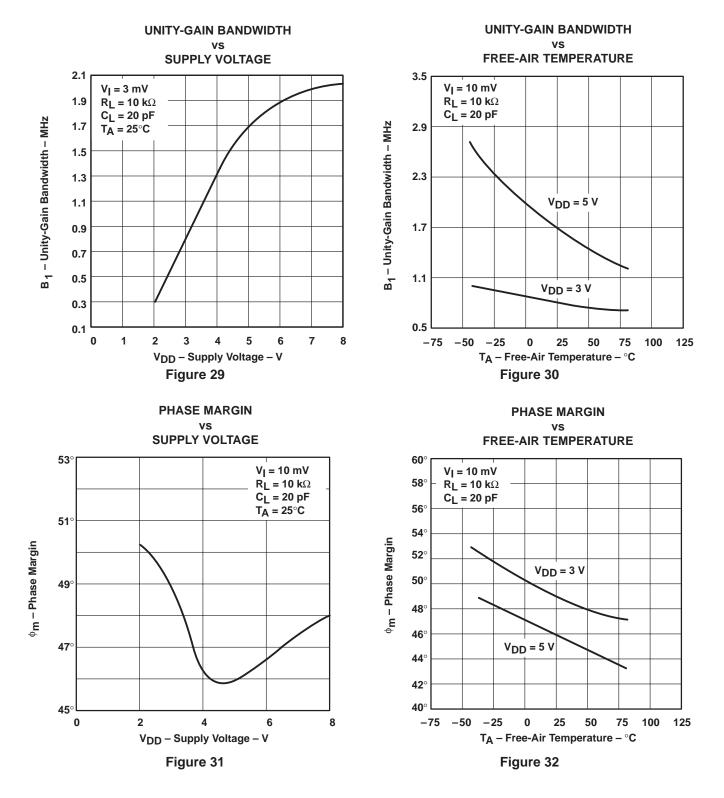


TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997



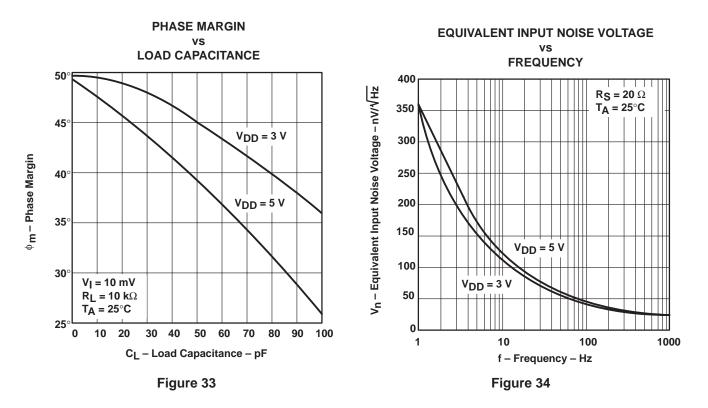


TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997





TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997

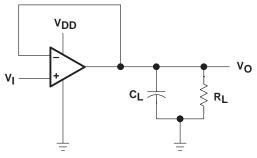




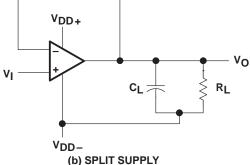
PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

Because the TLV234x is optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

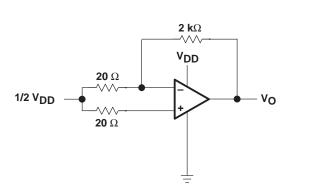




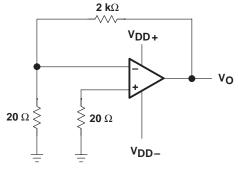




(0)

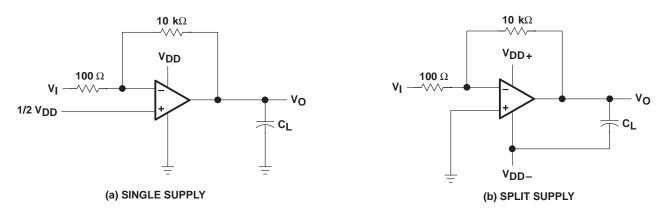


(a) SINGLE SUPPLY



(b) SPLIT SUPPLY









TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 - FEBRUARY 1997

PARAMETER MEASUREMENT INFORMATION

input bias current

Because of the high input impedance of the TLV234x operational amplifier, attempts to measure the input bias current can result in erroneous readings. The bias current at normal ambient temperature is typically less than 1 pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

- Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 38). Leakages that would otherwise flow to the inputs are shunted away.
- Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the open-socket leakage readings from the readings obtained with a device in the test socket.

Many automatic testers as well as some bench-top operational amplifier testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into a test socket to obtain a correct reading; therefore, an open-socket reading is not feasible using this method.

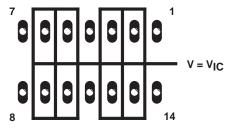


Figure 38. Isolation Metal Around Device Inputs (N or P package)

low-level output voltage

To obtain low-level supply-voltage operation, some compromise is necessary in the input stage. This compromise results in the device low-level output voltage being dependent on both the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions should be observed. If conditions other than these are to be used, please refer to the Typical Characteristics section of this data sheet.

input offset voltage temperature coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture results in leakage and contact resistance which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal itself, thereby rendering it useless. These measurements should be performed at temperatures above freezing to minimize error.

full-power response

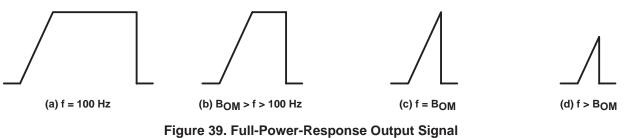
Full-power response, the frequency above which the operational amplifier slew rate limits the output voltage swing, is often specified two ways: full-linear response and full-peak response. The full-linear response is



PARAMETER MEASUREMENT INFORMATION

generally measured by monitoring the distortion level of the output while increasing the frequency of a sinusoidal input signal until the maximum frequency is found above which the output contains significant distortion. The full-peak response is defined as the maximum output frequency, without regard to distortion, above which full peak-to-peak output swing cannot be maintained.

Because there is no industry-wide accepted value for significant distortion, the full-peak response is specified in this data sheet and is measured using the circuit of Figure 35. The initial setup involves the use of a sinusoidal input to determine the maximum peak-to-peak output of the device (the amplitude of the sinusoidal wave is increased until clipping occurs). The sinusoidal wave is then replaced with a square wave of the same amplitude. The frequency is then increased until the maximum peak-to-peak output can no longer be maintained (Figure 39). A square wave is used to allow a more accurate determination of the point at which the maximum peak-to-peak output is reached.



test time

Inadequate test time is a frequent problem, especially when testing CMOS devices in a high-volume, short-test-time environment. Internal capacitances are inherently higher in CMOS than in bipolar and BiFET devices, and require longer test times than their bipolar and BiFET counterparts. The problem becomes more pronounced with reduced supply levels and lower temperatures.

APPLICATION INFORMATION

single-supply operation

While the TLV234x performs well using dualpower supplies (also called balanced or split supplies), the design is optimized for singlesupply operation. This includes an input commonmode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 2 V, thus allowing operation with supply levels commonly available for TTL and HCMOS.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. This virtual ground can be generated using two large resistors, but a preferred technique is to use a virtual-ground generator such as the TLE2426 (see Figure 40).

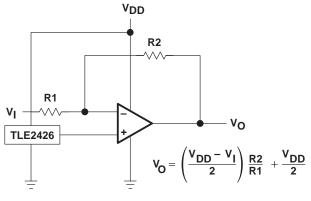


Figure 40. Inverting Amplifier With Voltage Reference



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 – FEBRUARY 1997

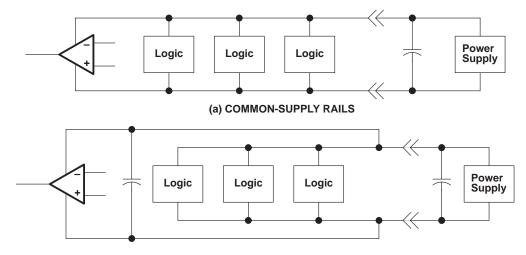
APPLICATION INFORMATION

single-supply operation (continued)

The TLE2426 supplies an accurate voltage equal to $V_{DD}/2$ while consuming very little power and is suitable for supply voltages of greater than 4 V.

The TLV234x works well in conjunction with digital logic; however, when powering both linear devices and digital logic from the same power supply, the following precautions are recommended:

- Power the linear devices from separate bypassed supply lines (see Figure 41); otherwise, the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic.
- Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, RC decoupling may be necessary in high-frequency applications.



(b) SEPARATE-BYPASSED SUPPLY RAILS (preferred)

Figure 41. Common Versus Separate Supply Rails

input characteristics

The TLV234x is specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. The lower range limit includes the negative rail, while the upper range limit is specified at $V_{DD} - 1 V$ at $T_A = 25^{\circ}C$ and at $V_{DD} - 1.2 V$ at all other temperatures.

The use of the polysilicon-gate process and the careful input circuit design gives the TLV234x very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically $0.1 \,\mu$ V/month, including the first month of operation.

Because of the extremely high input impedance and resulting low bias-current requirements, the TLV234x is well suited for low-level signal processing; however, leakage currents on printed-circuit boards and sockets can easily exceed bias-current requirements and cause a degradation in device performance.



APPLICATION INFORMATION

input characteristics (continued)

It is good practice to include guard rings around inputs (similar to those of Figure 38 in the Parameter Measurement Information section). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 42).

The inputs of any unused amplifiers should be tied to ground to avoid possible oscillation.

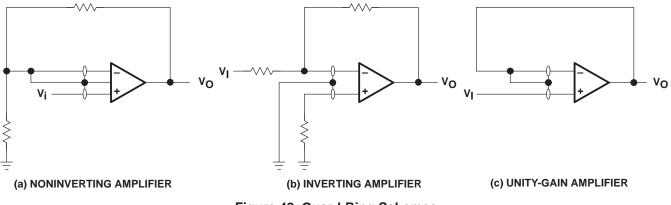


Figure 42. Guard-Ring Schemes

noise performance

The noise specifications in operational amplifier circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias-current requirements of the TLV234x results in a very low noise current, which is insignificant in most applications. This feature makes the device especially favorable over bipolar devices when using values of circuit impedance greater than 50 k Ω , since bipolar devices exhibit greater noise currents.

feedback

Operational amplifiers circuits nearly always employ feedback, and since feedback is the first prerequisite for oscillation, a little caution is appropriate. Most oscillation problems result from driving capacitive loads and ignoring stray input capacitance. A small-value capacitor connected in parallel with the feedback resistor is an effective remedy (see Figure 43). The value of this capacitor is optimized empirically.

electrostatic-discharge protection

Figure 43. Compensation for Input Capacitance

The TLV234x incorporates an internal electrostatic-discharge (ESD)-protection circuit that prevents functional failures at voltages up to 2000 V as tested under MIL-PRF-38535. Method 3015.2. Care should be exercised, however, when handling these devices as exposure to ESD may result in the degradation of the device parametric performance. The protection circuit also causes the input bias currents to be temperature dependent and have the characteristics of a reverse-biased diode.



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS

SLOS194 - FEBRUARY 1997

APPLICATION INFORMATION

latch-up

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLV234x inputs and outputs are designed to withstand -100-mA surge currents without sustaining latch-up; however, techniques should be used to reduce the chance of latch-up whenever possible. Internal protection diodes should not by design be forward biased. Applied input and output voltage should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 µF typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the positive supply rail and ground and can be triggered by surges on the supply lines and/or voltages on either the output or inputs that exceed the supply voltage. Once latch-up occurs, the current flow is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor and usually results in the destruction of the device. The chance of latch-up occurring increases with increasing temperature and supply voltages.

output characteristics

The output stage of the TLV234x is designed to sink and source relatively high amounts of current (see Typical Characteristics). If the output is subjected to a short-circuit condition, this high-current capability can cause device damage under certain conditions. Output current capability increases with supply voltage.

Although the TLV234x possesses excellent high-level output voltage and current capability, methods are available for boosting this capability if needed. The simplest method involves the use of a pullup resistor (Rp) connected from the output to the positive supply rail (see Figure 44). There are two disadvantages to the use of this circuit. First, the NMOS pulldown transistor N4 (see equivalent schematic) must sink a comparatively large amount of current. In this circuit, N4 behaves like a linear resistor with an on resistance between approximately 60 Ω and 180 Ω , depending on how hard the operational amplifier input is driven. With very low values of RP, a voltage offset from 0 V at the output occurs. Secondly, pullup resistor Rp acts as a drain load to N4 and the gain of the operational amplifier is reduced at output voltage levels where N5 is not supplying the output current.

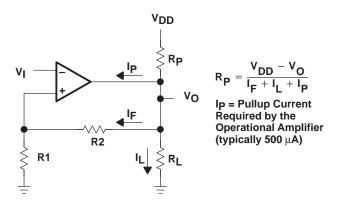


Figure 44. Resistive Pullup to Increase VOH

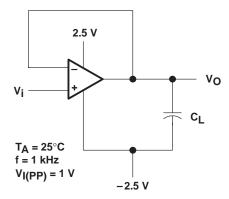


Figure 45. Test Circuit for Output Characteristics

All operating characteristics of the TLV234x are measured using a 20-pF load. The device drives higher capacitive loads; however, as output load capacitance increases, the resulting response pole occurs at lower frequencies thereby causing ringing, peaking, or even oscillation (see Figure 45 and Figure 46). In many cases, adding some compensation in the form of a series resistor in the feedback loop alleviates the problem.



TLV2342, TLV2342Y, TLV2344, TLV2344Y LinCMOS[™] LOW-VOLTAGE HIGH-SPEED OPERATIONAL AMPLIFIERS SLOS194 - FEBRUARY 1997

TYPICAL APPLICATION DATA

output characteristics (continued)

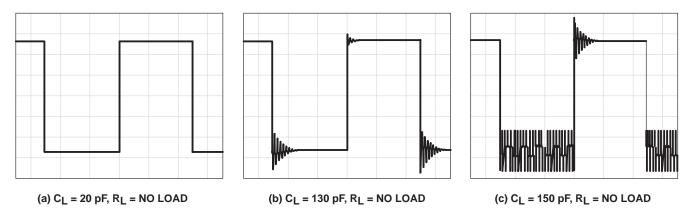


Figure 46. Effect of Capacitive Loads





PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
TLV2342ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	23421	Samples
TLV2342IP	ACTIVE	PDIP	Р	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	TLV2342IP	Samples
TLV2342IPW	ACTIVE	TSSOP	PW	8	150	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TY2342	Samples
TLV2344IN	ACTIVE	PDIP	Ν	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	TLV2344IN	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and



www.ti.com

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TEXAS INSTRUMENTS

www.ti.com

25-Oct-2024

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
TLV2342ID	D	SOIC	8	75	507	8	3940	4.32
TLV2342ID	D	SOIC	8	75	505.46	6.76	3810	4
TLV2342IP	Р	PDIP	8	50	506	13.97	11230	4.32
TLV2342IPW	PW	TSSOP	8	150	530	10.2	3600	3.5
TLV2344IN	N	PDIP	14	25	506	13.97	11230	4.32

P(R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 variation BA.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



PW0008A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153, variation AA.



PW0008A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0008A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

D0008A



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



D0008A

EXAMPLE BOARD LAYOUT

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



D0008A

EXAMPLE STENCIL DESIGN

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated